Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/580,426	MATSUI ET AL.
Examiner	Art Unit
Chau N. Nguyen	2831

SEARCHED				
Class	Subclass	Date	Examiner	
174	113R	2/22/2007	CN	
	102R			
174	108	7/18/2007	CN	
		·		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
see p	rint out	7/18/2007	CN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Text	2/22/2007	CN	